

A) Test with simple  $H_0$ : for  $H_0$ : true,  $\theta = \theta_0$ ,  $\exists$  unique null distribution of  $X$ ,  $F(x)$ .

• t-test for Normal Sampling:  $X \sim N(\mu, \sigma^2)$  unknown  $\Rightarrow \bar{t} = \frac{\bar{X}_n - \mu_0}{\sqrt{s^2/n}} \sim G_0 = t_{n-1} \Rightarrow$  rejects  $H_0$  if  $|\bar{t}| > q_{1-\alpha/2}$   
 $H_0: \mu = \mu_0$   $\Rightarrow \bar{t} = \frac{\bar{X}_n - \mu_0}{\sqrt{s^2/n}} \sim G_0 = t_{n-1} \Rightarrow$  rejects  $H_0$  in favor of  $H_1: \mu > \mu_0$  if  $\bar{t} > q_{1-\alpha}$   
 $\Rightarrow H_1: \mu < \mu_0$  if  $\bar{t} < -q_{1-\alpha}$   
 $\Rightarrow H_1: \mu \neq \mu_0$  if  $|\bar{t}| > q_{1-\alpha/2}$

• asymptotic t-test:  $X \sim$  unknown  $\Rightarrow \bar{t} = \frac{\bar{X}_n - \mu_0}{\sqrt{s^2/n}} \xrightarrow{n \rightarrow \infty} N(0,1) \Rightarrow$  rejects  $H_0$  in favor of  $H_1: \mu > \mu_0$  if  $\bar{t} > z_{1-\alpha}$   
 $\Rightarrow H_1: \mu < \mu_0$  if  $\bar{t} < -z_{1-\alpha}$   
 $\Rightarrow H_1: \mu \neq \mu_0$  if  $|\bar{t}| > z_{1-\alpha/2}$

• general asymptotic t-test: Let  $\theta$ : parameter of interest,  $\hat{\theta}$ : estimator of  $\theta$ ,  $s(\hat{\theta})$ : standard error  $\xrightarrow[\text{standard conditions}]{\text{under}} \frac{\hat{\theta} - \theta_0}{s(\hat{\theta})} \xrightarrow{n \rightarrow \infty} N(0,1) \Rightarrow$  We can perform an asymptotic t-test under the null hypothesis  $H_0: \theta = \theta_0$   
 $T = \frac{\hat{\theta} - \theta_0}{s(\hat{\theta})} \xrightarrow{n \rightarrow \infty} G_0 = N(0,1)$

• Likelihood Ratio Test

Let  $X \sim f(x|\theta)$   
 $H_0: \theta = \theta_0, H_1: \theta \neq \theta_0$

$$T = \frac{\ln(\hat{\theta})}{\ln(\theta_0)} \text{ or equivalently } LR_n = 2(\ln(\hat{\theta}) - \ln(\theta_0))$$

rejects  $H_0$  if  $LR_n > c$  with  $c: P[LR_n < c | \theta_0] = \alpha$   
 does not follow a "known" distribution. We can use asymptotic!

• asymptotic likelihood ratio test

$$LR_n = \frac{(\hat{\theta} - \theta_0)^2}{\hat{V}} + o_p(1) \xrightarrow{n \rightarrow \infty} \chi_m^2$$

where  $\chi_m^2$ : chi-distribution  
 $\hat{V} = [-\frac{1}{n} \frac{d^2}{d\theta^2} \ln(\theta) | \hat{\theta}]^{-1}$

• Connection of  $LR_n$ -test and t-test

- As  $n \rightarrow \infty$  the tests "Reject  $H_0$  if  $LR_n > c$ " and "Reject  $H_0$  if  $|\bar{t}| > c$ " are asymptotically equivalent
- If  $X \sim N(\theta, \sigma^2)$  with  $\sigma^2$  known and for the test  $H_0: \theta = \theta_0$  and  $H_1: \theta > \theta_0$  ( $H_1: \theta < \theta_0$ ) the  $LR$ -test and  $t$ -test are equivalent
- Among all simple  $H_0$ -tests the LR is the most powerful. Thus in some case the  $t$ -test is also.

B) Test with composite  $H_0$ : for  $H_0$ : true,  $\theta = \theta_0$ ,  $\exists$  unique distribution  $F(x) \{X \sim f(x|\theta), H_0: \mu = \mu_0, f_0(x) = f(x|\mu_0)\}$

Let  $X$  with known parametric  $F(x|\theta = (\theta_1, \dots, \theta_k))$ .  $\theta = h(\beta)$ : scalar parameter of interest  $\Rightarrow \{H_0: \theta = \theta_0, H_1: \theta \neq \theta_0\}$

$$LR_n = 2(\ln(\hat{\beta}) - \ln(\bar{\beta})) \text{ where } \hat{\beta} = \max_{\beta} \ln(\beta) \text{ and } \bar{\beta} = \max_{\beta \in \theta_0} \ln(\beta) \Rightarrow \text{reject } H_0 \text{ if } LR_n > c \text{ with } c: P[LR_n > c | \theta_0] = \alpha$$

! If  $X \sim N(\mu, \sigma^2)$ : LR-test  $H_0: \mu = \mu_0, H_1: \mu \neq \mu_0$  equivalent to  $t$ -test  $H_0: \mu = \mu_0, H_1: \mu \neq \mu_0$